



## SSCU180N20GS9

### N-Channel Enhancement Mode MOSFET with ESD Protection

#### ➤ Features

$V_{DS}$	$V_{GS}$	$R_{DS(ON)}$ Typ.	$I_D$
20V	$\pm 12V$	180m $\Omega$ @4V5	1.2A
		230m $\Omega$ @2V5	
		330m $\Omega$ @1V8	

#### ➤ Description

This device is a N-Channel enhancement mode MOSFET, which is produced with high cell density and DMOS trench technology. This device particularly suits low voltage applications, especially for battery powered circuits, the tiny and thin outline saves PCB consumption.

***this device has ESD protection structure.***

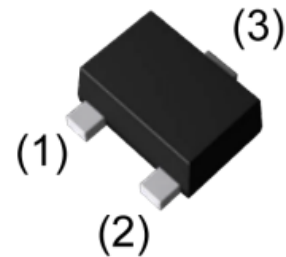
#### ➤ Applications

- Replace Digital Transistor
- Battery Operated Systems
- Power Supply Converter Circuits
- Load/Power Switching cell Phones

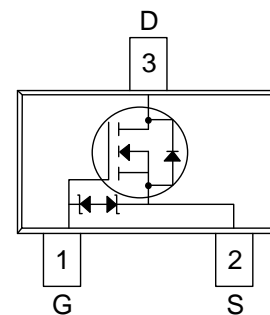
#### ➤ Ordering Information

Device	Package	Shipping
SSCU180N20GS9	SOT-723	8000/Reel

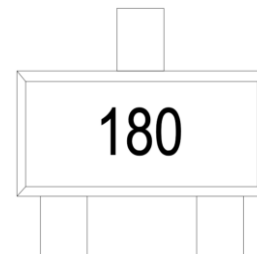
#### ➤ Pin configuration



**SOT-723**



**Pin Configuration (Top View)**



**Marking**



➤ **Absolute Maximum Ratings ( $T_A=25^{\circ}\text{C}$  unless otherwise noted)**

Symbol	Parameter	Ratings	Unit
$V_{DSS}$	Drain-to-Source Voltage	20	V
$V_{GSS}$	Gate-to-Source Voltage	$\pm 12$	V
$I_D$	Continuous Drain Current <sup>a</sup>	1.2	A
$I_{DM}$	Pulsed Drain Current <sup>b</sup>	4.8	A
$P_D$	Power Dissipation <sup>c</sup>	0.3	W
$T_J$	Operation junction temperature	-55~150	$^{\circ}\text{C}$
$T_{STG}$	Storage temperature range	-55~150	$^{\circ}\text{C}$

➤ **Thermal Resistance Ratings ( $T_A=25^{\circ}\text{C}$  unless otherwise noted)**

Symbol	Parameter	Typical	Maximum	Unit
$R_{\theta JA}$	Junction-to-Ambient Thermal Resistance <sup>a</sup>	320	416	$^{\circ}\text{C}/\text{W}$

Note:

- The value of  $R_{\theta JA}$  is measured with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz.copper, in a still air environment with  $T_A=25^{\circ}\text{C}$ . The value in any given application depends on the user is specific board design. The power dissipation is based on the  $t \leq 10\text{s}$  thermal resistance rating.
- Repetitive rating, pulse width limited by junction temperature.
- The power dissipation  $P_D$  is based on  $T_{J(MAX)}=150^{\circ}\text{C}$ , using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heat sinking is used.



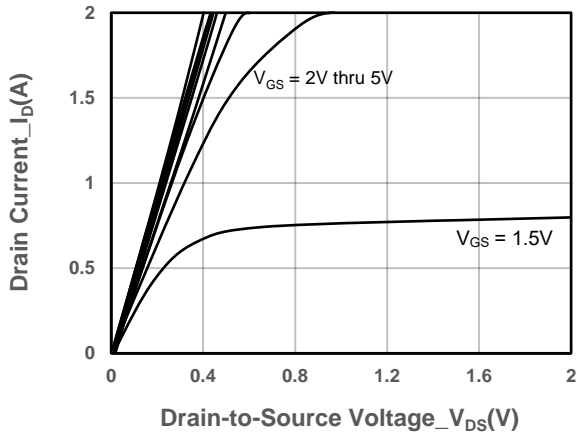
# SSCU180N20GS9

## ➤ Electrical Characteristics (T<sub>A</sub>=25°C unless otherwise noted)

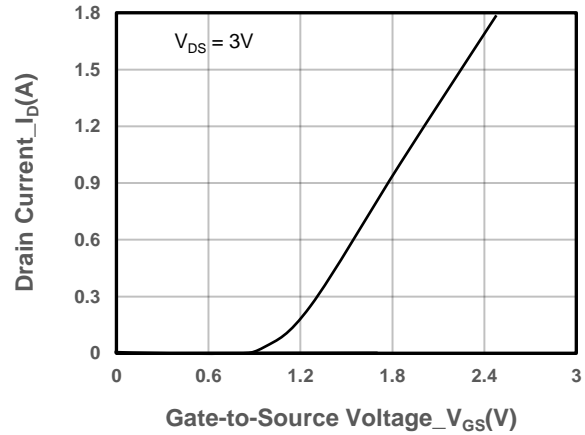
Parameter	Symbol	Test Conditions	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage	V <sub>(BR)DSS</sub>	V <sub>GS</sub> = 0V, I <sub>D</sub> = 250uA	20			V
Gate Threshold Voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250uA	0.35	0.6	1	V
Drain-Source On-Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 0.6A		180	450	mΩ
		V <sub>GS</sub> = 2.5V, I <sub>D</sub> = 0.5A		230	765	
		V <sub>GS</sub> = 1.8V, I <sub>D</sub> = 0.35A		330	1300	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 16V, V <sub>GS</sub> = 0V			1	μA
Gate-Source Leak Current	I <sub>GSS</sub>	V <sub>GS</sub> = ±12V, V <sub>DS</sub> = 0V			±10	μA
Transconductance	G <sub>FS</sub>	V <sub>DS</sub> = 5V, I <sub>D</sub> = 0.5A		11		s
Forward Voltage	V <sub>SD</sub>	V <sub>GS</sub> = 0V, I <sub>S</sub> = 0.15A		0.7	1.3	V
Input Capacitance	C <sub>ISS</sub>	V <sub>DS</sub> = 16V, V <sub>GS</sub> = 0V, f = 200KHz		53		pF
Output Capacitance	C <sub>OSS</sub>			15		
Reverse Transfer Capacitance	C <sub>RSS</sub>			12		
Turn-on Delay Time	T <sub>D(ON)</sub>	V <sub>GS</sub> = 4.5V, V <sub>DS</sub> = 10V, I <sub>D</sub> = 0.5A		6.2		ns
Rise Time	T <sub>r</sub>			4.9		
Turn-off Delay Time	T <sub>D(OFF)</sub>			18.5		
Fall Time	T <sub>f</sub>			7.7		
Total Gate Charge	Q <sub>G</sub>	V <sub>GS</sub> = 10V, V <sub>DS</sub> = 15V I <sub>D</sub> = 0.2A		1.2		nC
Gate to Source Charge	Q <sub>GS</sub>			0.16		
Gate to Drain Charge	Q <sub>GD</sub>			0.15		



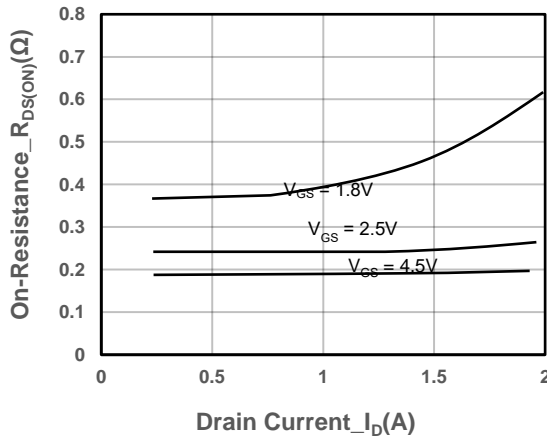
## ➤ Typical Performance Characteristics ( $T_A = 25^\circ\text{C}$ unless otherwise noted)



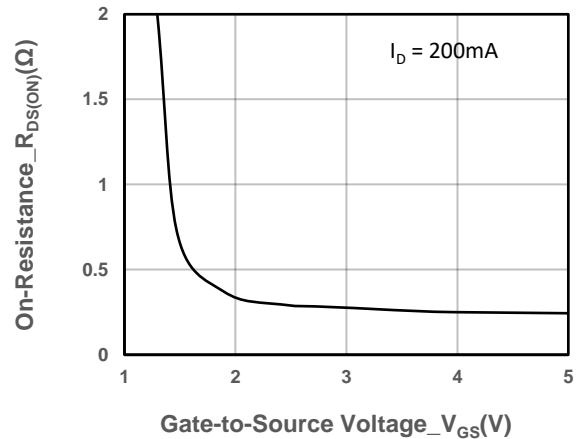
Output Characteristics



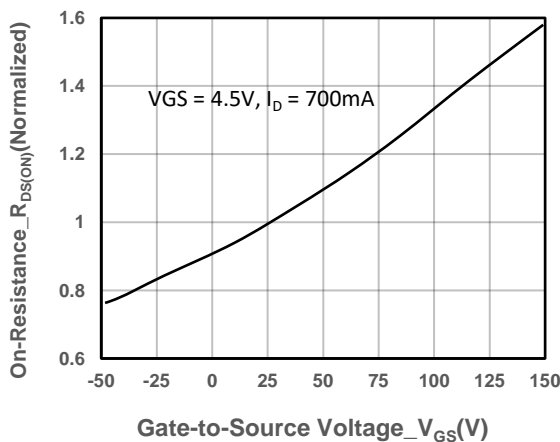
Transfer Characteristics



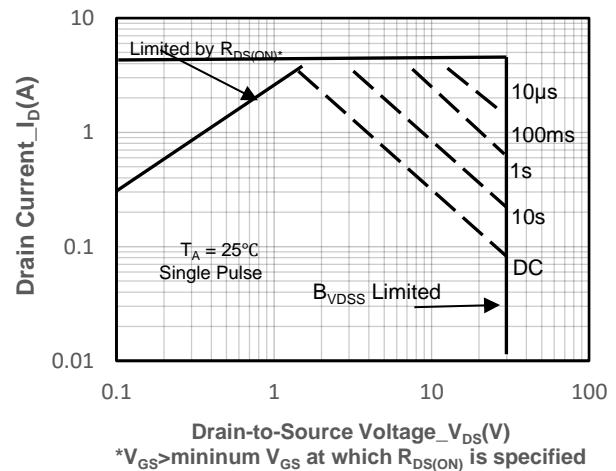
On-Resistance vs. Drain Current and Gate Voltage



On-Resistance vs. Gate-to-Source Voltage



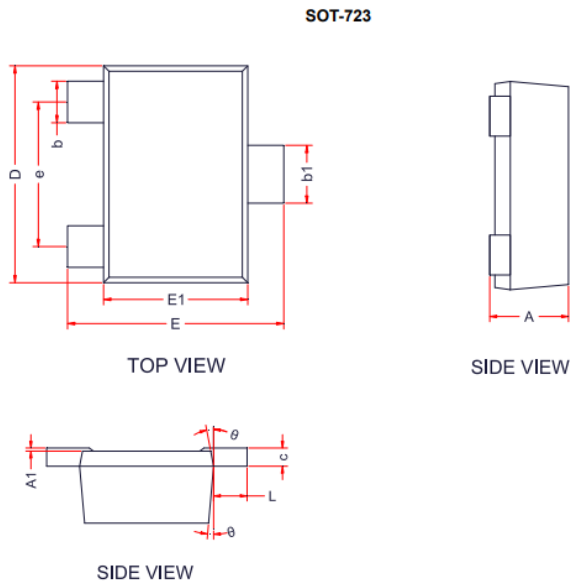
On-Resistance vs. Junction Temperature



Safe Operating Area vs. Junction-to-Ambient

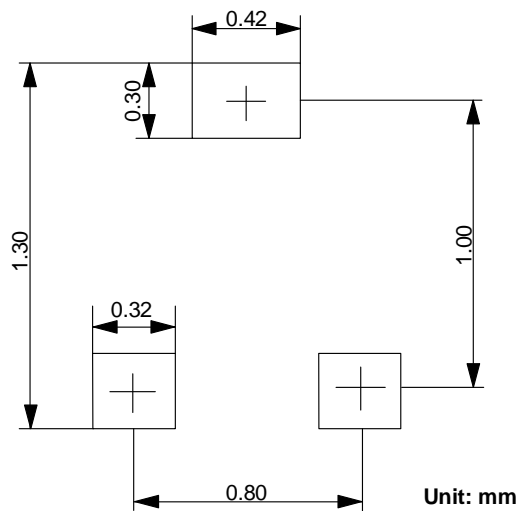


## ➤ Package Information



DIM	Millimeters		
	Min.	Typ.	Max.
<b>A</b>	0.43	-	0.55
<b>A1</b>	0.00	-	0.05
<b>b1</b>	0.27		0.37
<b>b</b>	0.17	-	0.27
<b>c</b>	0.08	0.13	0.18
<b>D</b>	1.15	1.20	1.25
<b>E</b>	1.15	1.20	1.25
<b>E1</b>	0.75	0.8	0.85
<b>e</b>	0.80Ref.		
<b>L</b>	0.15	0.2	0.25
<b>θ</b>	7°Ref.		

## ➤ Suggested Pad Layout





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